	<u> </u>				
QUERY CONTROL FORM			RTIS USE ONLY		
Application No. 091625 214	Prepared by	JB	Tracking Number	5998192	
Examiner-GAU (1000) - 3764	Date	911104	Week Date	BILLIM	
	No. of queries	ĺ	1 FW		

JACKET					
a. Serial No.	f. Foreign Priority	k. Print Claim(s)	(p. PTO-1449)		
b. Applicant(s)	g. Disclaimer	I. Print Fig.	q. PTOL-85b		
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract		
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs		
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other		

	~
SPECIFICATION	MESSAGE
a. Page Missing	PTD-1449: PKASE either initial or line 4hough Citations). Copy provided for reference.
b. Text Continuity	Citations). Commovoided for reference.
c. Holes through Data	
d. Other Missing Text	
e. Illegible Text	,
f. Duplicate Text	
g. Brief Description	
h. Sequence Listing	
i. Appendix	
j. Amendments	
k. Other	
CLAIMS	
a. Claim(s) Missing	
b. Improper Dependency	
c. Duplicate Numbers	Thank va
d. Incorrect Numbering	initials (16)
e. Index Disagrees	RESPONSE
f. Punctuation	
g. Amendments	
h. Bracketing	
i. Missing Text	
j. Duplicate Text	
k. Other	
	initials

Ch-ne	2	-6
2000	1	α

FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office LIST OF ART CITED BY APPLICANT				Docket No.: 11509 B		Serial No.:	NIA C 244J	
					ם בטבוג	17.102	7 - 244	
				Applicant: Hai Pin KUO				
(Use	several si	neets if necessary)						
· · · · · · · · · · · · · · · · · · ·					Filing D	ate: N/A	Group: N//	4
				U.S. Patent Document	LS	•		······································
*Examiner Initial		Document Number	issue Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA	5,279,528	01/18/94	Dalebout et al.	482	- 54	05/15/	1992
	AB							
	AC							
	AD	·						
	AE							
	AF						·	
	AG							
	AH							•
	AI							
	AJ							
	AK			•				
Fore	ign Paten	z Documents	.1		··		· · ·	
Trac	slation							
		Document Number	Date	Country	Class	Subclass	Yα	No
•	AL							
	AM							
	AN							
	AO		· ·				. ,	
	AP			•				
017	ER ART	(Including Author	r, Title, Date, P	ertinent Pages, Etc.)				
	AR				-			
	AS					•	*	
	AT					·······		
Examiner			Date Consider	ed ·				